

Search Notes

Application/Control No.

10/561,957

Examiner

SEYED MASOUD
MALEKZADEHApplicant(s)/Patent under
Reexamination

NISHIZAWA, TSUYOSHI

Art Unit

1722

SEARCHED

Class	Subclass	Date	Examiner
438	456	3/28/2007	SMM
438	149	3/28/2007	SMM
438	156	3/29/2007	SMM
257	758	3/29/2007	SMM
117	84	9/21/2007	SMM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Use Palm Intranet to search inventor's name	3/28/2007	SMM
Use text search through East to find patents related to the application Examiner used key words such "silicon wafer"	3/28/2007	SMM
Updated previous search	9/21/2007	SMM